SPECIFICATION

Product Model: YX240QV29-T (Rev.A)

Designed by	R&D Checked by	Quality Department by	Approved by

Approval by Customer

OK

NG, Problem survey:

Approved By _____

Revision Record

REV NO.	REV DATE	CONTENTS	Note
Α	2014-12-02	NEW ISSUE	

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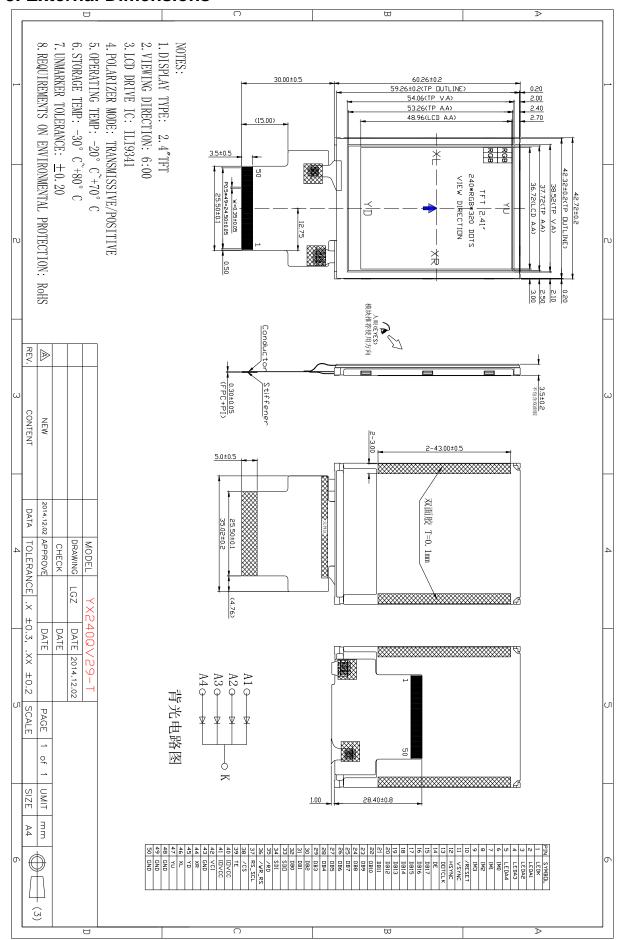
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1. Numbering System

2. General Information

ITEM	STANDARD VALUES	UNITS
LCD type	2.4"TFT	
Dot arrangement	240(RGB)×320	dots
Color filter array	RGB vertical stripe	
Display mode	TN / Transmission / Normally White	
Viewing Direction	6 o'clock	
Driver IC	ILI9341	
Module size	42.72(W)×60.26(H)×3.5(T)	mm
Active area	36.72(W)×48.96(H)	mm
Dot pitch	0.153 (W)×0.153 (H)	mm
Interface	4-lines_8bit / 3-lines_9bit SPI 8-/ 9-/16-/18-bit 8080-series system interface 6-/16-/18-bit RGB interface	
Operating temperature	-20 ~ +70	င
Storage temperature	-30 ~ +80	${\mathbb C}$
Back Light	4 White LED In Parallel	
Weight	TBD	g

3. External Dimensions



4. Interface Description

<u>4. I</u>	nterrace	Description					
Pin	Symbol	Description.					
1	LEDK	LED backlight (Cathode).					
2	LEDA1	LED backlight (Anode).					
3	LEDA2	LED backlight (Anode).					
4	LEDA3	LED backlight (Anode).					
5	LEDA4	LED backlight (Anode).					
		System interface Mode					
6	IMO	IM3 IM2 IM1 IM0 Interface mode DB Pin					
		0 0 0 0 i80-system 8-bit interface I DB[7:0]					
		0 0 0 1 i80-system 16-bit interface I DB[15:0] 0 0 1 0 i80-system 9-bit interface I DB[8:0]					
7	IM1	0 0 1 1 i80-system 18-bit interface I DB[17:0]					
		0 1 0 1 3-wires_9-bit SPI I /CS,SDI,SCL					
		0 1 1 0 4-wires_8-bit SPI I /CS,RS,SDI,SCL					
8	IM2	1 0 0 0 i80-system 16-bit interface II DB[17:10],DB[8:1]					
		1 0 0 1 i80-system 8-bit interface Ⅱ DB[17:10] 1 0 1 0 i80-system 18-bit interface Ⅱ DB[17:0]					
		1 0 1 1 i80-system ro-bit interface II DB[17:0]					
9	IM3	1 1 0 1 3-wires_9-bit SPI II /CS,SDI,SDO,SCL					
		1 1 1 0 4-wires_8-bit SPI II /CS,RS,SDI,SDO,SCL					
10	/RESET	Reset input pin, Active "L".					
11	VSYNC	Vertical sync signal in RGB I/F.					
12	HSYNC	Horizontal sync signal in RGB I/F.					
13	DOTCLK	Pixel clock signal in RGB I/F.					
14	DE	Data enable signal in RGB I/F mode					
15	DB17						
16	DB16						
17	DB15	16-bit parallel bi-directional data bus for MPU- I system:					
18	DB14	8-bit I/F: DB[7:0] is used.					
19	DB13	9-bit I/F: DB[8:0] is used. 16-bit I/F: DB[15:0] is used.					
20	DB12	18-bit I/F: DB[17:0] is used.					
21	DB11						
22	DB10	18-bit parallel bi-directional data bus for MPU- II system:					
23	DB9	8-bit I/F: DB[17:10] is used. 9-bit I/F: DB[17:9] is used.					
24	DB8	9-bit i/F. DB[17:9] is used. 16-bit l/F: DB[17:10] and DB[8:1] is used.					
25	DB7	18-bit I/F: DB[17:0] is used.					
26	DB6						
27	DB5	18-bit input data bus for RGB I/F.					
28	DB4	6-bit/pixel: DB[5:0] is used; 16-bit/pixel: DB[17:13]=R[4:0], DB[11:6]=G[5:0] and DB[5:1]=B[4:0];					
29	DB3	18-bit/pixel: DB[17:13]=R[4:0], DB[11:0]=G[5:0] and DB[5:0]=B[5:0];					
30	DB2	Connect unused pins to GND.					
31	DB1						
32	DB0						
33	SDO	Serial output signal in SPI I/F.					

34	SDI	Serial input signal in SPI I/F.
35	/RD	Reads strobe signal to write data when /RD is "Low" in MPU interface.
36	/WR_RS	MCU: Serves as a write signal and writes data at the rising edge. 4-line SPI: Serves as command or parameter select.
37	RS_SCL	Display data / command selection in 80-series MPU I/F. RS = "0" : Command RS = "1" : Display data. SPI: This pin is used serial interface clock in SPI.
38	/CS	Chip select input pin ("Low" enable) in MPU I/F and SPI I/F.
39	TE	Tearing effect output pin to synchronize MPU to frame writing.
40	IOVCC	I/O power supply.
41	IOVCC	I/O power supply.
42	VCI	System power supply.
43	GND	Power ground
44	XR	
45	YD	TOUCH PIN.
46	XL	TOOCH PIN.
47	YU	
48	GND	Power ground
49	GND	Power ground
50	GND	Power ground

5. Absolute Maximum Ratings

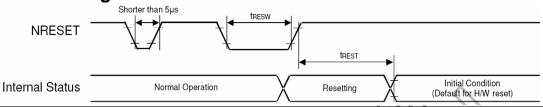
Item	Symbol	Min.	Max.	Unit
Logic Supply Voltage	IOVCC	-0.3	4.6	V
Analog Supply Voltage	VCI	-0.3	4.6	V
Input Voltage	Vin	-0.3	IOVCC+0.3	V
Operating Temperature	Тор	-20	70	°C
Storage Temperature	Тѕт	-30	80	°C
Storage Humidity	HD	20	90	%RH

6. DC Characteristics

Item	Symbol	Min.	Тур.	Max.	Unit	Remark
Logic Supply Voltage	IOVCC	1.65	1.8/2.8	3.3	٧	-
Analog Supply Voltage	VCI	2.5	2.8	3.3	٧	-
Input High Voltage	V _{IH}	0.7IOVCC	-	IOVCC	٧	Digital input pins
Input Low Voltage	V _{IL}	GND	-	0.3IOVCC	٧	Digital input pins
Output High Voltage	V _{OH}	0.8IOVCC	1	IOVCC	V	Digital output pins
Output Low Voltage	V_{OL}	GND	-	0.2IOVCC	٧	Digital output pins
I/O Leak Current	lu	-0.1	ı	0.1	uA	-

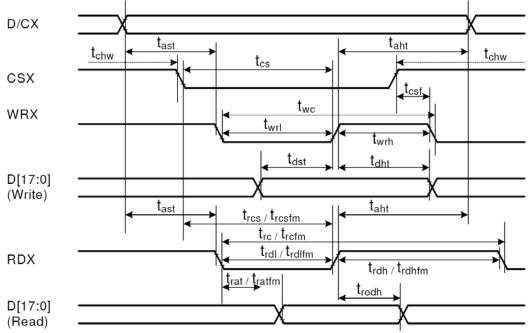
7. Timing Characteristics

7.1 Reset Timing Characteristics



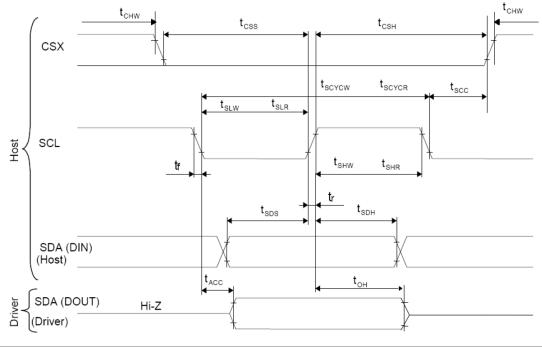
Symbol Parameter		Related		Spec.		Note	Unit
Syllibol	Faranietei	Pins	Min.	Тур.	Max.	Note	Oilit
tRESW	Reset low pulse width ⁽¹⁾	NRESET	10	-	- (/	_	μs
tREST	Reset complete time ⁽²⁾	-	5	~((A)	When reset applied during SLPIN mode	ms
INEST	neset complete time	-	120	(0))_	When reset applied during SLPOUT mode	ms

7.2 i80-System Interface Timing Characteristics



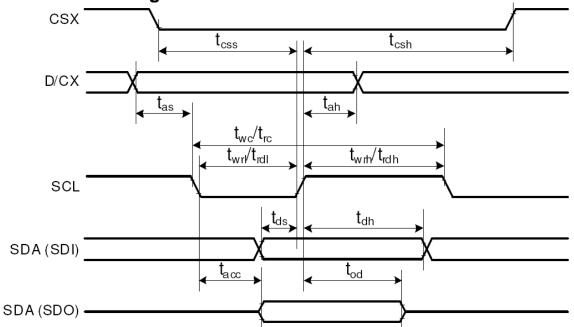
Signal	Symbo I	Parameter	min	max	Unit	Description
DCX	tast	Address setup time	0	-	ns	
DCX	taht	Address hold time (Write/Read)	0	-	ns	
	tchw	CSX "H" pulse width	0	-	ns	
	tcs	Chip Select setup time (Write)	15	-	ns	
CSX	trcs	Chip Select setup time (Read ID)	45	-	ns	
	trcsfm	Chip Select setup time (Read FM)	355	-	ns	
	tcsf	Chip Select Wait time (Write/Read)	10	-	ns	
	twc	Write cycle	66	-	ns	
WRX	twrh	Write Control pulse H duration	15	-	ns	
	twrl	Write Control pulse L duration	15	-	ns	
	trcfm	Read Cycle (FM)	450	-	ns	
RDX (FM)	trdhfm	Read Control H duration (FM)	90	-	ns	
	trdlfm	Read Control L duration (FM)	355	-	ns	
	trc	Read cycle (ID)	160	-	ns	
RDX (ID)	trdh	Read Control pulse H duration	90	-	ns	
	trdl	Read Control pulse L duration	45	-	ns	
D[47.0]	tdst	Write data setup time	10	-	ns	
D[17:0], D[17:10]&D[8:1], D[17:10],	tdht	Write data hold time	10	-	ns	For maximum CL=30pF
	trat	Read access time	-	40	ns	For minimum CL=30PF
D[17:10], D[17:9]	tratfm	Read access time	-	340	ns	1 or minimum oc-opi
5[17.0]	trod	Read output disable time	20	80	ns	

7.3 3-line SPI Timing Characteristics



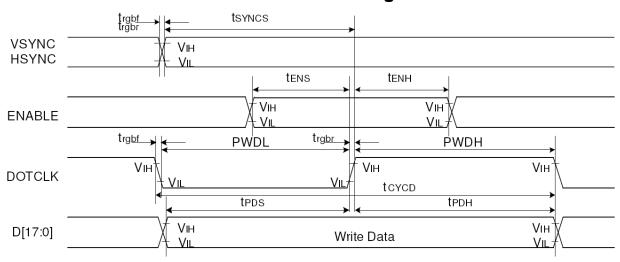
Signal	Symbol	Parameter	min	max	Unit	Description
	tscycw	Serial Clock Cycle (Write)	100	-	ns	
	tshw	SCL "H" Pulse Width (Write)	40	-	ns	
SCL	tslw	SCL "L" Pulse Width (Write)	40	-	ns	
SOL	tscycr	Serial Clock Cycle (Read)	150	-	ns	
	tshr	SCL "H" Pulse Width (Read)	60	-	ns	
	tslr	SCL "L" Pulse Width (Read)	60	-	ns	
SDA / SDI	tsds	Data setup time (Write)	30	-	ns	
(Input)	tsdh	Data hold time (Write)	30	-	ns	
SDA / SDO	tacc	Access time (Read)	10	-	ns	
(Output)	toh	Output disable time (Read)	10	50	ns	
	tscc	SCL-CSX	20	-	ns	
CSX	tchw	CSX "H" Pulse Width	40	-	ns	
CSX	tcss	CSX-SCL Time	60	-	ns	
	tcsh	CSX-SOL TITTE	65	-	ns	

7.4 4-line SPI Timing Characteristics



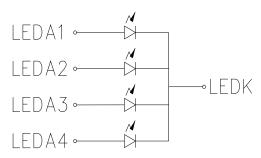
Signal	Symbol	Parameter	min	max	Unit	Description
CSX	tcss	Chip select time (Write)	40	-	ns	
037	tcsh	Chip select hold time (Read)	40	-	ns	
	twc	Serial clock cycle (Write)	100	-	ns	
	twrh	SCL "H" pulse width (Write)	40	-	ns	
001	twrl	SCL "L" pulse width (Write)	40	-	ns	
SCL	trc	Serial clock cycle (Read)	150	-	ns	
	trdh	SCL "H" pulse width (Read)	60	-	ns	
	trdl	SCL "L" pulse width (Read)	60	-	ns	
D/CV	tas	D/CX setup time	10	-		
D/CX	tah	D/CX hold time (Write / Read)	10	-		
SDA / SDI	tds	Data setup time (Write)	30	-	ns	
(Input)	tdh	Data hold time (Write)	30	-	ns	
SDA / SDO	tacc	Access time (Read)	10	-	ns	For maximum CL=30pF
(Output)	tod	Output disable time (Read)	10	50	ns	For minimum CL=8pF

7.5 Parallel 18/16/6-bit RGB Interface Timing Characteristics



Signal	Symbol	Parameter	min	max	Unit	Description
VSYNC /	tsyncs	VSYNC/HSYNC setup time	15	-	ns	
HSYNC	t _{SYNCH}	VSYNC/HSYNC hold time	15	-	ns	
DE	t _{ENS}	DE setup time	15	-	ns	
DE	t _{ENH}	DE hold time	15	-	ns	
D[17:0]	t _{POS}	Data setup time	15	-	ns	18/16-bit bus RGB
D[17.0]	t _{PDH}	Data hold time	15	-	ns	interface mode
	PWDH	DOTCLK high-level period	15	-	ns	
DOTOLK	PWDL	DOTCLK low-level period	15	-	ns	
DOTCER	tcycd	DOTCLK cycle time	100	-	ns	
	t _{rgbr} , t _{rgbf}	DOTCLK,HSYNC,VSYNC rise/fall time	-	15	ns	
VSYNC /	tsyncs	VSYNC/HSYNC setup time	15	-	ns	
HSYNC	t _{SYNCH}	VSYNC/HSYNC hold time	15	-	ns	
סר	t _{ENS}	DE setup time	15	-	ns	
DE	t _{ENH}	DE hold time	15	-	ns	
D[17:0]	t _{POS}	Data setup time	15	-	ns	6-bit bus RGB
[٥٠/١]ط	t _{PDH}	Data hold time	15	-	ns	interface mode
	PWDH	DOTCLK high-level pulse period	15	-	ns	
DOTOLK	PWDL	DOTCLK low-level pulse period	15	-	ns	
DOTCER	HSYNC	DOTCLK cycle time	100	-	ns	
	t _{rgbr} , t _{rgbf}	DOTCLK,HSYNC,VSYNC rise/fall time	-	15	ns	

8. Backlight Charasterics



Item	Symbol	MIN	TYP	MAX	UNIT	Test Condition
Supply Voltage	Vf	2.9	3.2	3.5	V	If=60mA
Supply Current	lf	-	60	80	mA	-
Luminous Intensity for LCM	-	180	230	-	Cd/m ²	If=60mA
Uniformity for LCM	-	80	-	-	%	If=60mA
Life Time	-	20000	-	-	Hr	If=60mA
Backlight Color				White		

9. Optical Characteristics

Item		Symbol	Condition	Min.	Тур.	Max.	Unit	Note
Transmittance (without Polarizer)		T(%)	_		(14.4)	_		
Contrast Ratio)	CR	⊖=0	400	500	_	_	(1)(2)
	Rising	T _R	Normal viewing		4	8		
Response time	Falling	T _F	angle —		12	24	msec	(1)(3)
Color gamut	Color gamut				60		%	
	White	W _x		0.283	0.303	0.323		
		Wy		0.305	0.325	0.345		
	Red	Rx		0.606	0.626	0.646		
Color		Ry		0.314	0.334	0.354		(1)(4)
chromaticity	Green	Gx		0.257	0.277	0.297		CF glass
(CIE1931)		Gy		0.529	0.549	0.569		(C-light)
	Dive	Bx		0.122	0.142	0.162		
	Blue	Ву		0.102	0.122	0.142		
	Han	θL		35	45			
	Hor.	Θ_{R}	OD: 40	35	45	_		
Viewing angle	\/	θυ	CR>10	35	45			
	Ver.	θρ		10	20	_		
Optima View D	Direction		12 O'clock					

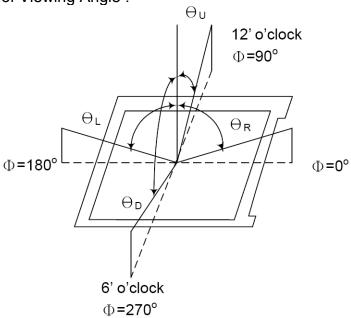
Measuring Condition:

Dark room, 25±2℃, 15min. warm-up time.

Measuring Equipment

FPM520 of Westar Display technologies, INC., which utilized SR-3 for Chromaticity and BM-5A for other optical characteristics.

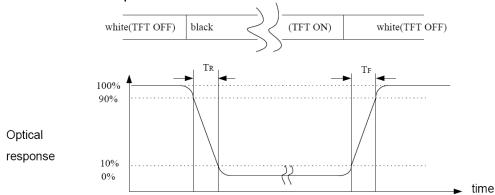
Note (1) Definition of Viewing Angle:



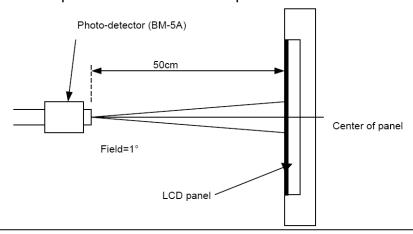
Note (2) Definition of Contrast Ratio(CR) : Measured at the center point of panel

CR = Luminance with all pixels white / Luminance with all pixels black

Note (3) Definition of Response Time: Sum of TR and TF



Note (4) Definition of optical measurement setup



10. Reliability Test Conditions And Methods

NO.	TEST ITEMS	TEST CONDITION	INSPECTION AFTER TEST
1	High Temperature Storage	80℃±2℃×200Hours	
2	Low Temperature Storage	-30°C±2°C×200Hours	
3	High Temperature Operating	70℃±2℃×120Hours	Inspection after 2~4hours
4	Low Temperature Operating	-20℃±2℃×120Hours	storage at room temperature,the samples should be free from
5	Temperature Cycle(Storage)	$ \begin{array}{cccccccccccccccccccccccccccccccccccc$	defects: 1,Air bublle in the LCD. 2,Sealleak. 3,Non-display. 4,Missing segments.
6	Damp Proof Test (Storage)	50℃±5℃×90%RH×120Hours	5,Glass crack. 6,Current IDD is twice higher than initial value.
7	Vibration Test	Frequency:10Hz~55Hz~10Hz Amplitude:1.5M X,Y,Z direction for total 3hours (Packing Condition)	7,The surface shall be free from damage. 8,The electric charateristic requirements shall be
8	Drooping Test	Drop to the ground from 1M height one time every side of carton. (Packing Condition)	satisfied.
9	ESD Test	Voltage:±8KV,R:330Ω,C:150PF,Air Mode,10times	

REMARK:

- 1,The Test samples should be applied to only one test item.
- 2, Sample side for each test item is 5~10pcs.
- 3, For Damp Proof Test, Pure water (Resistance $> 10 \text{M}\Omega$) should be used.
- 4,In case of malfunction defect caused by ESD damage,if it would be recovered to normal state after resetting,it would be judge as a good part.
- 5,EL evaluation should be excepted from reliability test with humidity and temperature:Some defects such as black spot/blemish can happen by natural chemical reaction with humidity and Fluorescence EL has.
- 6, Failure Judgment Criterion: Basic Specification Electrical Characteristic, Mechanical Characteristic, Optical Characteristic.

11. Inspection Standard

This standard apply to C-STN/TFT module

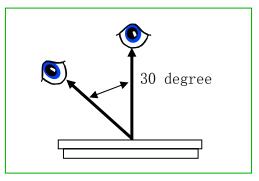
1. Spot check plan:

According to spot check level ${\rm II}$,MIL-STD-105D Level ${\rm II}$,the rank of accept or reject is below:

3A 级、2A 级:major non-conformance:AQL 0.25 minor non-conformance:AQL 0.4

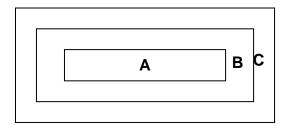
A级: major non-conformance: AQL 0.65 minor non-conformance: AQL 1.

2. Inspection condition:



Under daylight lamp 20 \sim 40W, product distance inspector'eye 30cm,incline degree 30°.

3. LCD area define:



Area A: display area

Area B: VA area

Area C: out of VA area, not in sight after assemby

Remark :non-conformance at area C,but is OK that isn't influence raliability of product & assembly by customer.

4. Inspection standard

4.1 Major non-conformance

NO.	Item	Inspection standard	Rate	
4.1.1	Function non-confor mance	 No display, display abnormaly Miss line, short B/L no function or function abnormaly TP no function 	major	
4.1.2	miss	No matter miss what component	.,	
4.1.3	Out of size	Module dimension out of spec		

4.2 Appearance non-conformance

NO.	Item		Rate						
4.2.1		dot non-conformance define Φ $\Phi = \frac{(x+y)}{2}$							
		A grade	rea		Most ap	prove	q'ty		
	Black or	size (mm)		Α	В		С		
	white spot	Ф≤0.10	0		ignore				Minor
	(power on)	0.10<Φ≤	0.15		3				
		0.15<Φ≤	0.20		2		ignore		
		0.20<Φ≤0.25			1				
		0.25<Ф			0				
		Most approve 4 damages, dot to dot ≥10mm							
		A grade			Т				_
		Size(mm)			Most approve of			q'ty	
		L(length)	W(w	ridth)	Α		В	С	
	Black or	ignore	W≤	0.03	i,	gnore)		
4.2.2	white line (power	L≤5.0		3< 0.05	2				Minor
	on)	L≤3.0		05< 0.07	1			ignore	
			0.07	′ <w< td=""><td>Trea</td><td>t with</td><td></td><td></td><td></td></w<>	Trea	t with			
		Most approve 3 damages, line to line ≥10mm							

4.2.3	Polarizer position	 polarizer attach meet drawing, disallow out of LCD. polarizer must cover display area (special require unless) 								
4.2.4	LCD non-conf ormance	(ii) com	X ≤3. Crash dinonly surrespondent to the second to the	0 isallow exists a scale of the	Y SS SETO length Y SS Stend to ITO The Y Frame edge	ię	Z gnore al. Z ignore		Minor	
4.2.5	Contrast voltage warp	VOP/VIc	VOP/VIcd voltage of confirmed sample±0.15V							
4.2.6	color	Color &	Color & luminance of module scope reference spec							
4.2.7	Cross talk	Reference	ce confirm	ed limit s	ample				Minor	

12. Handling Precautions

12.1 Mounting method

The LCD panel of SC LCD module consists of two thin glass plates with polarizes which easily be damaged. And since the module in so constructed as to be fixed by utilizing fitting holes in the printed circuit board.

Extreme care should be needed when handling the LCD modules.

12.2 Caution of LCD handling and cleaning

When cleaning the display surface, Use soft cloth with solvent

[recommended below] and wipe lightly

- Isopropyl alcohol
- Ethyl alcohol

Do not wipe the display surface with dry or hard materials that will damage the polarizer surface.

Do not use the following solvent:

- Water
- Aromatics

Do not wipe ITO pad area with the dry or hard materials that will damage the ITO patterns Do not use the following solvent on the pad or prevent it from being contaminated:

- Soldering flux
- Chlorine (Cl), Salfur (S)

If goods were sent without being sili8con coated on the pad, ITO patterns could be damaged due to the corrosion as time goes on.

If ITO corrosion happen by miss-handling or using some materials such as Chlorine (CI), Salfur (S) from customer, Responsibility is on customer.

12.3 Caution against static charge

The LCD module use C-MOS LSI drivers, so we recommended that you:

Connect any unused input terminal to Vdd or Vss, do not input any signals before power is turned on, and ground your body, work/assembly areas, assembly equipment to protect against static electricity.

12.4 packing

- Module employ LCD elements and must be treated as such.
- Avoid intense shock and falls from a height.
- To prevent modules from degradation, do not operate or store them exposed direct to sunshine or high temperature/humidity

12.5 Caution for operation

- It is an indispensable condition to drive LCD's within the specified voltage limit since the higher voltage then the limit cause the shorter LCD life.
- An electrochemical reaction due to direct current causes LCD's undesirable deterioration, so that the use of direct current drive should be avoided.
- Response time will be extremely delayed at lower temperature then the operating temperature range and on the other hand at higher temperature LCD's how dark color in them. However those phenomena do not mean malfunction or out of order with LCD's, which will come back in the specified operation temperature.
- If the display area is pushed hard during operation, some font will be abnormally displayed but it resumes normal condition after turning off once.
- A slight dew depositing on terminals is a cause for electro-chemical reaction resulting in terminal open circuit.

Usage under the maximum operating temperature, 50%Rh or less is required.

12.6 storage

In the case of storing for a long period of time for instance, for years for the purpose or replacement use, the following ways are recommended.

- Storage in a polyethylene bag with the opening sealed so as not to enter fresh air outside in it . And with no desiccant.
- Placing in a dark place where neither exposure to direct sunlight nor light's keeping the storage temperature range.

Storing with no touch on polarizer surface by the anything else.
 [It is recommended to store them as they have been contained in the inner container at the time of delivery from us

12.7 Safety

- It is recommendable to crash damaged or unnecessary LCD's into pieces and wash off liquid crystal by either of solvents such as acetone and ethanol, which should be burned up later.
- When any liquid leaked out of a damaged glass cell comes in contact with your hands, please wash it off well with soap and water

13. Precaution For Use

13.1

A limit sample should be provided by the both parties on an occasion when the both parties agreed its necessity. Judgment by a limit sample shall take effect after the limit sample has been established and confirmed by the both parties.

13.2

On the following occasions, the handing of problem should be decided through discussion and agreement between responsible of the both parties.

- When a question is arisen in this specification
- When a new problem is arisen which is not specified in this specifications
- When an inspection specifications change or operating condition change in customer is reported to GT LCD, and some problem is arisen in this specification due to the change
- When a new problem is arisen at the customer's operating set for sample evaluation in the customer site.

14. Packing Method

